DATE: 2010.07.21

CUSTOMER: James Electronics Ltd.

DESCRIPTION: Electrolytic Capacitor

SPEC.: LHK Series 10 uF 450 V 105 °C 13x21

P/N:LHK100M450V1321

| BUYER'S APPROVAL STAMP | APPROVED BY: | TESTED BY: |
|------------------------|--------------|------------|
| | Q A 陳信民 | 簡易達 |
| | 2010.07.21 | 2010.07.21 |

HONJU TAIWAN CO., LTD

JACKCON CAPACITOR ELECTRONICS CO., LTD.

SUPPLIER: JACKCON CAPACITOR ELECTRONICS CO., LTD.

5F, NO.88, SHING DE ROAD, SAN CHUNG CITY,

TAIPEI COUNTY, TAIWAN

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105℃ LHKseries

● 規格書

| Item | | | | | Per | form | ance | Cha | racto | eristi | cs | | | |
|---|---|--|----|----|-----|-------|--------|-------|--------|--------|-------|------|-----|-----|
| Operating Temperature Range(℃) | -4 | -40+105°C 6.3 to 100VDC -25+105°C 160 to 4 | | | | | to 45 | 50VD | C | | | | | |
| Capacitance Tolerance (%) | | | | | | | ±20 | % | | | | | | |
| Rated Voltage Range(v) | 6.3 | 10 | 16 | 25 | 35 | 50 | 63 | 100 | 160 | 200 | 250 | 350 | 400 | 450 |
| | 23 | 20 | 16 | 14 | 12 | 10 | 10 | 10 | 15 | 15 | 16 | 20 | 20 | 20 |
| Dissipation Factor(tan δ %)max. | For Capacitance > 1000uF, add 2% per another 1000uF (+20°C, at 120Hz) | | | | | | | | | | | | | |
| Leakage Current (LC.) (μΑ /after 1 min.)max. | I≤0.01 CV or 3(uA) After 1 minute whichever is greater measured With rated working voltage applied With rated working voltage applied | | | | | | | | | | | | | |
| Life Test: Load Life Test: | Δ C/C Within $\pm 20\%$ of the initial value | | | | | | | | | | | | | |
| After 2000 Hrs at 105°C | Т | an δ | • | | ≦ | 2009 | 6 of 1 | he in | nitial | spec | ified | valu | ie | |
| Shelf Life Test: After 500 Hrs at 105℃ | | LC. ≤The initial specified value | | | | | | | | | | | | |
| Detail specifications | | | | | Co | onfor | m to | IEC 6 | 50384 | l-4 | | | | |

Spec. & RIPPLE CURRENT:

| uF | WV | SIZE(DxL) | Maximum Ripple Current |
|----|-----|-----------|-------------------------|
| 10 | 450 | 13X21 | 92mA,rms,120Hz at 105°C |

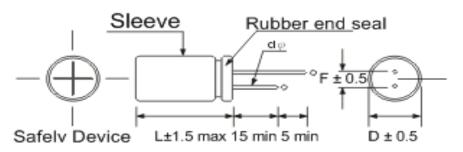
Temperature Multipliers Dimensions

| remperature murcipiters Dimensions | | | | | | | | | | | | | | | |
|------------------------------------|------|------|-------|------|------|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|
| Temp(°C) 1 | 105 | 85 | 85 70 | 60 | 45 | ¢ D | 5 | 6.3 | 8 | 10 | 13 | 16 | 18 | 22 | 25 |
| | 105 | | | | | F | 2.0 | 2.5 | 3.5 | 5.0 | 5.0 | 7.5 | 7.5 | 10 | 12 |
| Multiplier | 1.00 | 1.40 | 1.65 | 1.90 | 2.10 | ¢ d | 0.5 | 0.5 | 0.5 | 0.6 | 0.6 | 0.8 | 0.8 | 0.8 | 1.0 |

Multiplier for Ripple Current VS, Frequency

| CAP(uF)Hz | | 50(60) | 120 | 400 | 1K | 10K | 50K~100K |
|------------|--|--------|-----|------|------|------|----------|
| | CAP≤10 | 0.8 | 1 | 1.30 | 1.30 | 1.65 | 1.70 |
| | 10 <cap≤100< td=""><td>0.8</td><td>1</td><td>1.23</td><td>1.23</td><td>1.48</td><td>1.53</td></cap≤100<> | 0.8 | 1 | 1.23 | 1.23 | 1.48 | 1.53 |
| Multiplier | $100 < \text{CAP} \le 1000$ | 0.8 | 1 | 1.16 | 1.16 | 1.35 | 1.38 |
| | 1000 < CAP | 0.8 | 1 | 1.11 | 1.11 | 1.25 | 1.28 |

Unit: mm



CONTENTS OF QUALITY ASSURANCE

SCOPE

ASSURANCE METHOD CONTENTS

Performance

Unless otherwise specified, the capacitors shall be measured at +15°C to +35°C , 45to75%RH. However, if any Doubt arises on the judgment, the measurement conditions shall be +20 \pm 1°C, 60to70%RH the test Conditions shall comply with IEC-60384-4.

1. Capacitance (CAP.)

Measuring frequency :120Hz±20%

Measuring voltage :0.5V rms. +1.5 to 2.0V dc
Measuring circuit :Series equivalent circuit.

Criteria: Shall be within the specified capacitance tolerance.

2.Dissipation Factor (tan δ)

Measuring frequency :120Hz±20%

Measuring voltage :0.5V rms. +1.5 to 2.0V dc
Measuring circuit :Series equivalent circuit.

Criteria: Shall not exceed the specified in the table of Ratings.

3. Leakage Current (L.C.)

DC leakage current shall be measure with rate voltage, which is applied through a resistor of $1,000\pm10\,\Omega$ connected in series with the capacitors, at the end of a specified period after the capacitors reached the rated voltage across the terminals.

Criteria: Shall not exceed the specified in the table of Ratings.

4. Surge Voltage

- 4.1 The surge DC rating is the maximum voltage to which the capacitor should be subjected under any conditions. This includes transients and peak ripple at the highest line voltage.
- 4.2 Capacitors, connected in series with 1000 ohm resistors, shall withstand the surge test voltage applied at the rated of 1/2 minute on, 4 1/2 minutes off, for 1000 successive test cycles at 20°C (see the following table)

PERFORMANCE CHARACTERISTICS(continued)

Rated Voltage (WV) 6.3 10 16 25 35 50 63 100 160 200 250 350 400 450 Surge Voltage (SV) 10 13 20 32 44 63 79 125 200 250 300 400 450 500

Criteria: Capacitance change :≤±15% of initial value

Dissipation Factor :within specified value

Leakage Current :within specified value

Physical :no broken and undamaged

Endurance characteristic

| NO. | Item | Condition | | Specification |
|-----|---|---|--------------------|-----------------------------------|
| 5 | High temperature | Capacitors shall be placed in oven with application of ripple current | Capacitance change | Within ±20% of the initial value |
| | load life test | and rate voltage for 2000±12hrs at 105℃ | ΤΑΝ δ | Less then 200% of specified value |
| | | 2. The capacitors should be use within specified permissible ripple current | Leakage Current | Within specified value |
| | in each standard products table(the sum of DC working voltage and AC peak voltage shall be equal to the rated DC working voltage 3. The specified maximum permissible ripple current in defined at 105°C and 120 Hz 4. Then the capacitor shall be subjected to standard atmospheric conditions for 16 hours, after witch measurements shall be made. | | Physical | no broken and undamaged |
| 6. | High temperature | After 500hrs test at 105°C without rated working voltage. | Capacitance change | Within ±20% of the initial value |
| | shelf life test And then the capacitor shall be subjected to standard atmospheric conditions for 16 hours, after witch measurements shall be made. | | ΤΑΝ δ | Less then 200% of specified value |
| | | | Leakage Current | Within specified value |
| | | | Physical | no broken and undamaged |
| 7. | Rotational temperature | Capacitor is place in a oven whose temperature follow specific regulation | Capacitance change | Within ±10% of the initial value |
| | test | to change. The specific regulations is "+25°C (1 hr) \rightarrow +105°C (2 hrs) \rightarrow | ΤΑΝ δ | Within specified value |
| | | +25°C (0.5 hr) → -25 °C (2 hrs) → $+25$ °C (0.5 hr)", and it called a | Leakage Current | Within specified value |
| | cycle. The test totals 10 cycles. And then the capacitor shall be subjected to standard atmospheric conditions for 16 hours, after witch measurements shall be made. | | Physical | no broken and undamaged |
| 8. | Humidity test | Capacitors shall be exposed for 500± 8hrs in an atmosphere of 90~95%R.H | Capacitance change | Within ±10% of the initial value |
| | at 40°C. And then the capacitor sha | | ΤΑΝ δ | Less then 120% of specified value |
| | | conditions for 16 hours, after witch measurements shall be made. | Leakage Current | Within specified value |
| | | | Physical | no broken and undamaged |
| | | | | |

| | | | | - |
|-----|----------------------------|--|--|--|
| 9. | Low temperature test | Capacitor are place at -40±3°C for 72± 4hrs. And then the capacitor shall be subjected to standard atmospheric | Capacitance change TAN δ | Within ±10% of the initial value Within specified value |
| | | conditions for 16 hours, after witch measurements shall be made. | Leakage Current Physical | Within specified value no broken and undamaged |
| 10. | Vibration test | Fix it at the point 4mm or less form body. For ones of 12.5mm or 25mm or more length, use separate fixture. Direction and during of vibration:3 orthogonal direction each for 2hrs total 6hrs. Mutually frequency: 10 to55Hz reciprocation for 1 min. 4.Total amplitude:1.5mm | Capacitance change TAN δ Leakage Current Physical | Within ±10% of the initial value Within specified value Within specified value no broken and undamaged |
| 11. | Reflow test | 1. IR Reflow | Capacitance change | Within ±10% of the initial value |
| | | TEMP Time Preheat Temp (T1~T2) 100~150°C Time (t1) max 40 sec Duration Temp(T3) 260°C Time (t2) max 10 sec Peck Temp(T4) 270°C Time (t3) max 5 sec Reflow Twice or less cycle 2. Solder bath method: Solder temperature:260±3°C Immersion time:5+1/-0 sec Thickness of heat shunt (Printed wiring board):1.6mm 3. Soldering iron method: Bit temperature: 350±10°C Application time of soldering Iron:3+1/-0 sec | TAN δ Leakage Current Physical | Within specified value No broken and undamaged |

| 12. | Solderability test | After the lead wire fully immersed in the solder for 2 ± 0.1 sec at a temperature of 245 ± 2 °C, the solder coating must be more then 95% |
|-----|--------------------|--|
| 13. | Mechanical | The test is about lead tabs strength. Tension test: The lead tabs shall not be broken or any malformed condition after fixing capacitor vertically and pressing the following weight on the lead tabs of capacitor for 10±1 sec. Lead tabs diameter(mm) |
| | | 3. Bending test: |
| | | The capacitor is held in vertical position. Attach a weight to the lead tabs, slowly |
| | | rotate the capacitor 90° to a same way in the opposite direction. Repeat it again (5 secs |
| | | per cycle). The lead tabs shall not be broken or cracked. |
| | | Lead tabs diameter(mm) Weight(Kg) ≤ 0.5 0.5 |
| | | 0.5 |
| | | >0.8 |
| 14. | Safety vent | Condition: Apply a reverse voltage with current 1 amp.(DC reverse voltage test) Criteria: When the pressure relief vent operated, the capacitor shall not flame although gas generation or expulsion of a part of the inside element is allowable. If the vent does not operate with the voltage applied for 30 minutes, the test is |
| 15. | Standards | Considered to be passed. Satisfies Characteristic W of IEC-60384-4,18 |
| | | |

P. 4

CODE CONSTRUCTION

| LHK | 100 | M | 450 | V | 13 | 21 | |
|------------|--------------------|-----------------|-------------|------------|--------------------|------------|-------------|
| Series (1) | <u>Capacitance</u> | <u>Tol.</u> (3) | Voltage (4) | Sleeve (5) | <u>Dia.</u> (6) | Length (7) | Forming (8) |

(1) Series:

| LGK | LHK | LMK | LSM | LEK | LPS | LKP | LNP | LLK | LBP |
|-----|-----|-----|-----|-----|-----|-----|-----|-----|-----|

(2) Capacitance (uF):

| μF | 0.1 | 1 | 10 | 100 | 1000 | 10000 | 1.5 |
|------|------|-----|-----|-----|------|-------|------|
| Code | 0R1 | 010 | 100 | 101 | 102 | 103 | 1R5 |
| μF | 0.22 | 2.2 | 22 | 220 | 2200 | 22000 | 15 |
| Code | R22 | 2R2 | 220 | 221 | 222 | 223 | 150 |
| μF | 0.33 | 3.3 | 33 | 330 | 3300 | 33000 | 150 |
| Code | R33 | 3R3 | 330 | 331 | 332 | 333 | 151 |
| μF | 0.47 | 4.7 | 47 | 470 | 4700 | 47000 | 1500 |
| Code | R47 | 4R7 | 470 | 471 | 472 | 473 | 152 |

(3) Tolerance:

| Code | J | K | M | | |
|-----------|-----|------|------|--|--|
| Tolerance | ±5% | ±10% | ±20% | | |

(4) Working Voltage (V):

| <u> </u> | | o | | | | |
|----------|-----|--------------|-----|-----|-----|-----|
| 6.3 | 10 | 16 | 25 | 35 | 50 | 63 |
| 100 | 160 | 200 | 250 | 350 | 400 | 450 |

(5) Sleeve:

| Code | V | Е |
|--------|-----|-----|
| Sleeve | PVC | PET |

(6) Diameter (mm):

| \ / | | , | | | | | |
|------------|----|----|----|----|----|----|----|
| 4 | 5 | 6 | 8 | 10 | 13 | 16 | 18 |
| 22 | 25 | 30 | 35 | 51 | 64 | 77 | 90 |

(7) Length (mm):

| 5 | 7 | 9 | 11 | 12 | 14 | 16 | 20 | 21 | 25 |
|----|----|----|-----|-----|-----|-----|-----|-----|-----|
| 26 | 31 | 33 | 36 | 40 | 42 | 45 | 50 | 53 | 65 |
| 75 | 83 | 96 | 100 | 115 | 121 | 130 | 140 | 144 | 157 |

(8) Forming (optional):

| Taping + pitch (mm) | Cutting + length (mm) | Kink + pitch (mm) |
|---------------------|-----------------------|-------------------|
| TB2 | C3.3 | K5 |
| TB2.5 | C3.5 | |
| `TB3.5 | C5 | |
| TB5 | C7 | |

LABEL

FRONT

| JACKCON | Electrolytic | c Capacitor |
|--------------------|--------------|-------------|
| Capacitance Range: | 10 | uF |
| Voltage Range: | 450 | V |
| Quantity: | 250 | pcs |
| Remark: 13*21 | 105℃ | RoHS |
| MADE IN T | AIWAN | COMPLIANT |

Lot No : 8070313-000314

DATE LOT NO.

Marking

FRONT

JACKCON 10uF450V -25+105°C

BACK

02 (production line) 10C (date code) LHK



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JACKCON CAPACITOR ELECTRONICS CO., LTD. 5F., NO. 90, SHING DE ROAD, SAN CHUNG CITY, TAIPEI HSIEN, **TAIWAN**



The following sample(s) was/were submitted and identified by/on behalf of the client as:

JACKCON ELECTROLYTIC CAPACITOR Sample Description

Style/Item No. AL. ELECTROLYTIC CAPACITORS FULL RANGE

Sample Receiving Date 2009/12/03

Testing Period 2009/12/03 TO 2009/12/10

In accordance with the RoHS Directive 2002/95/EC, and its amendment **Test Requested**

directives.

With reference to IEC 62321: 2008 **Test Method**

Procedures for the Determination of Levels of Regulated Substances in

Electrotechnical Products.

(1) Determination of Cadmium by ICP-AES.

(2) Determination of Lead by ICP-AES.

(3) Determination of Mercury by ICP-AES.

(4) Determination of Hexavalent Chromium by UV/Vis Spectrometry.

(5) Determination of PBB and PBDE by GC/MS.

Test Result(s) Please refer to next page(s).

Chenyu Kung / Operation Manager Signed for and on behalf of

SGS TAIWAN LTD.

Chemical Laboratory - Taipei

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JACKCON CAPACITOR ELECTRONICS CO., LTD. 5F., NO. 90, SHING DE ROAD, SAN CHUNG CITY, TAIPEI HSIEN, **TAIWAN**



Test results by chemical method (Unit: mg/kg)

| Toot Itom (a): | Method | Result | MDL | |
|---|------------|--------|-----|--|
| Test Item (s): | (Refer to) | No.1 | | |
| Cadmium (Cd) | (1) | n.d. | 2 | |
| Lead (Pb) | (2) | n.d. | 2 | |
| Mercury (Hg) | (3) | n.d. | 2 | |
| Hexavalent Chromium Cr(VI) by alkaline extraction | (4) | n.d. | 2 | |
| Sum of PBBs | | n.d. | - | |
| Monobromobiphenyl | 1 | n.d. | 5 | |
| Dibromobiphenyl | 1 | n.d. | 5 | |
| Tribromobiphenyl | 1 | n.d. | 5 | |
| Tetrabromobiphenyl | 1 | n.d. | 5 | |
| Pentabromobiphenyl |] | n.d. | 5 | |
| Hexabromobiphenyl |] | n.d. | 5 | |
| Heptabromobiphenyl |] | n.d. | 5 | |
| Octabromobiphenyl |] | n.d. | 5 | |
| Nonabromobiphenyl |] | n.d. | 5 | |
| Decabromobiphenyl | (5) | n.d. | 5 | |
| Sum of PBDEs | (5) | n.d. | - | |
| Monobromodiphenyl ether |] | n.d. | 5 | |
| Dibromodiphenyl ether |] | n.d. | 5 | |
| Tribromodiphenyl ether |] | n.d. | 5 | |
| Tetrabromodiphenyl ether |] | n.d. | 5 | |
| Pentabromodiphenyl ether |] | n.d. | 5 | |
| Hexabromodiphenyl ether |] | n.d. | 5 | |
| Heptabromodiphenyl ether | | n.d. | 5 | |
| Octabromodiphenyl ether |] | n.d. | 5 | |
| Nonabromodiphenyl ether |] | n.d. | 5 | |
| Decabromodiphenyl ether |] | n.d. | 5 | |

TEST PART DESCRIPTION:

MIXED ALL PARTS

Note: 1. mg/kg = ppm; 0.1wt% = 1000ppm

2. n.d. = Not Detected

3. MDL = Method Detection Limit

4. "-" = Not Regulated

5. The sample(s) was/were analyzed on behalf of the applicant as mixing sample in one testing. The above result(s) was/were only given as the informality value.

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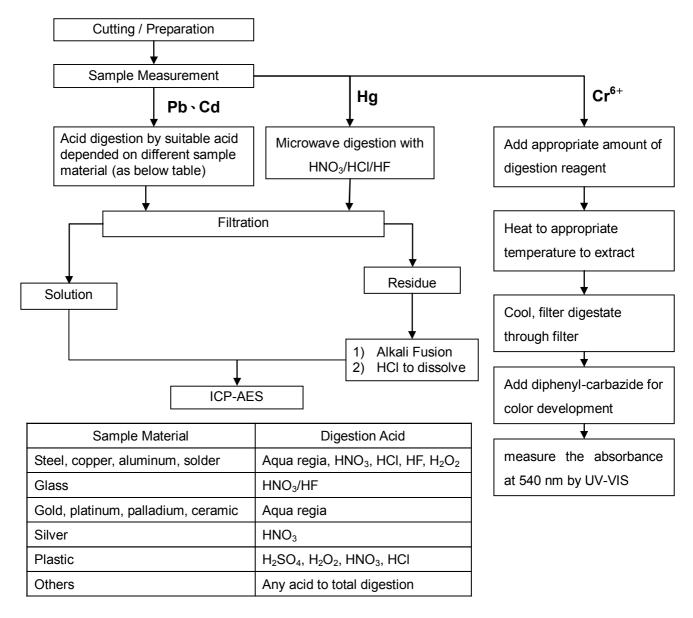


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JACKCON CAPACITOR ELECTRONICS CO., LTD. 5F., NO. 90, SHING DE ROAD, SAN CHUNG CITY, TAIPEI HSIEN, **TAIWAN**



- 1) These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr⁶⁺ test method excluded)
- 2) Name of the person who made measurement: Climbgreat Yang
- 3) Name of the person in charge of measurement: Troy Chang



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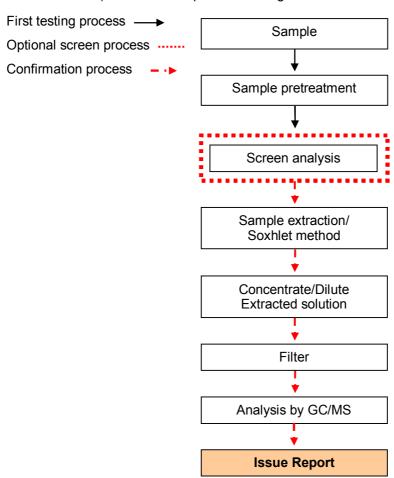
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JACKCON CAPACITOR ELECTRONICS CO., LTD. 5F., NO. 90, SHING DE ROAD, SAN CHUNG CITY, TAIPEI HSIEN, **TAIWAN**



PBB/PBDE analytical FLOW CHART

- 1) Name of the person who made measurement: Roman Wong
- 2) Name of the person in charge of measurement: Shinjyh Chen



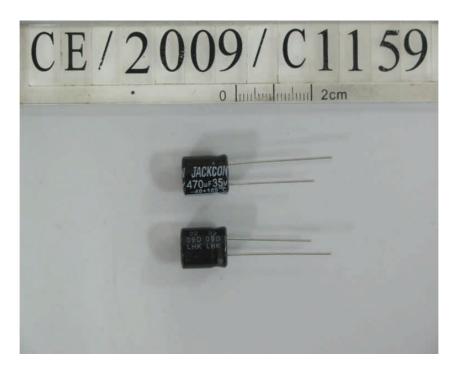
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JACKCON CAPACITOR ELECTRONICS CO., LTD. 5F., NO. 90, SHING DE ROAD, SAN CHUNG CITY, TAIPEI HSIEN, **TAIWAN**





** End of Report **

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